

isc N-Channel Mosfet Transistor

FQP33N10

• FEATURES

- Low $R_{DS(on)}$
- Silicon Gate for Fast Switching Speed
- Rugged
- Low Drive Requirements

• DESCRIPTION

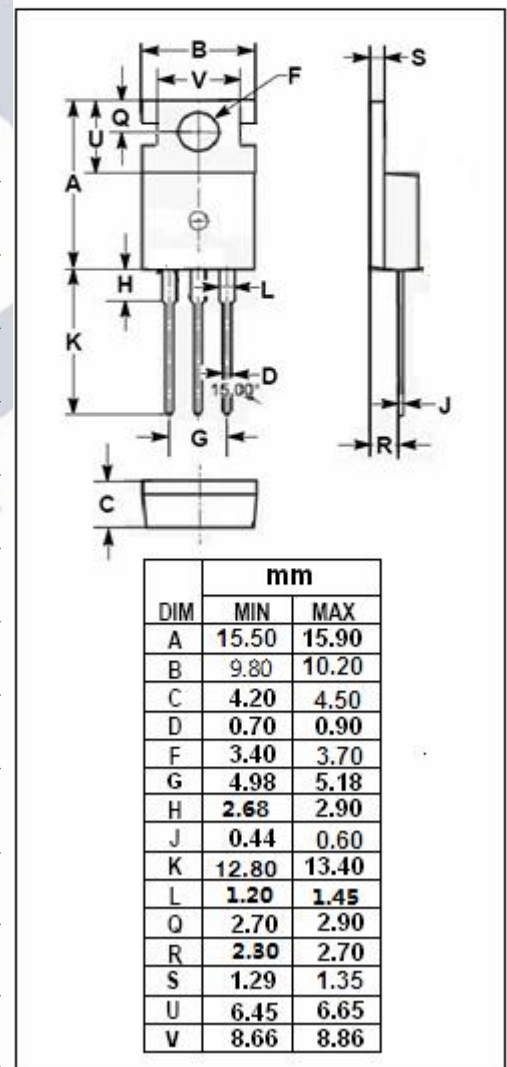
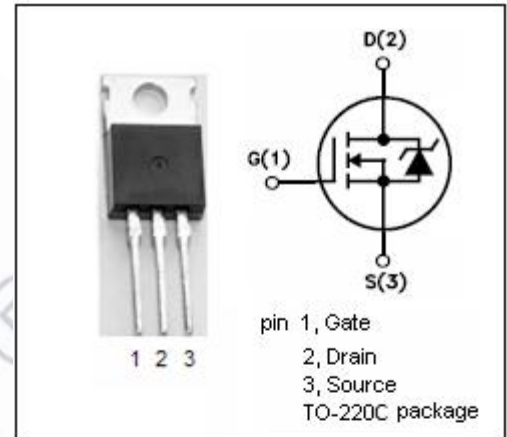
- Designed especially for low voltage applications such as Audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

• ABSOLUTE MAXIMUM RATINGS($T_a=25^{\circ}C$)

SYMBOL	PARAMETER	VALUE	UNIT
V_{DSS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage-Continuous	± 25	V
I_D	Drain Current-Continuous	33	A
I_{DM}	Drain Current-Single Pulsed	132	A
P_D	Total Dissipation @ $T_c=25^{\circ}C$	127	W
T_j	Max. Operating Junction Temperature	-55~175	$^{\circ}C$
T_{stg}	Storage Temperature	-55~175	$^{\circ}C$

• THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	MAX	UNIT
$R_{th j-c}$	Thermal Resistance, Junction to Case	1.18	$^{\circ}C/W$
$R_{th j-a}$	Thermal Resistance, Junction to Ambient	62.5	$^{\circ}C/W$



isc N-Channel Mosfet Transistor**FQP33N10****ELECTRICAL CHARACTERISTICS** $T_C=25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0; I_D=0.25\text{mA}$	100		V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}; I_D=0.25\text{mA}$	2	4	V
$R_{DS(on)}$	Drain-Source On-Resistance	$V_{GS}=10\text{V}; I_D=16.5\text{A}$		0.052	Ω
I_{GSS}	Gate-Body Leakage Current	$V_{GS}=\pm 25\text{V}; V_{DS}=0$		± 100	nA
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=100\text{V}; V_{GS}=0$		1.0	μA
V_{SD}	Forward On-Voltage	$I_S=33\text{A}; V_{GS}=0$		1.5	V
Gfs	Forward Transconductance	$V_{DS}=40\text{V}; I_D=16.5\text{A}$	22		S